

Sewon Park

125, Olympic-ro 35-gil, Songpa-gu, Seoul, Republic of Korea
swpark0413@gmail.com

RESEARCH INTEREST

My research interests lie at the intersection of Bayesian statistics and deep learning, with a particular focus on modeling tabular and time-series data. I have expertise in nonparametric Bayesian methods, synthetic data generation, time-series anomaly detection, and missing data analysis. My current work involves developing deep learning approaches for anomaly and insider threat detection, as well as exploring high-dimensional statistical methods and dimension reduction techniques, such as the envelope model.

WORK EXPERIENCE

Samsung SDS

September 2021 - Present

EDUCATION

Ph.D., Statistics

March 2015 - August 2021

Department of Statistics, Seoul National University, Seoul, Korea

- **Advisor:** Professor Jaeyong Lee.

Bachelor of Arts, Economics, Applied Statistics (Double Major)

February 2015

Department of Economics, Yonsei University, Gangwon, Korea

TEACHING EXPERIENCE

Teaching Assistant

Spring 2015 - Spring 2019

Seoul National University, Korea

- Mathematical Statistics 1 **Spring 2016, Spring 2019**
- Bayesian Statistics and Lab **Fall 2018**
- Regression Analysis and Lab **Spring 2018**
- Statistical computing and Lab **Fall 2016, Fall 2017**
- Statistical Consulting and Practices **Spring 2017**
- Statistics Concept and Lab **Fall 2015**
- Introduction to Statistics **Spring 2015**

HONORS & AWARDS

Winner of the 2023 T-SM Best Paper Award

January 2024

First prize winner in Graduate Student Paper Award (Korean Statistical Society)

Winter 2020

Brain Korea 21 Plus Scholarship (National Research Foundation)

Spring 2016 -

Spring 2019

Merit-based Scholarship (Seoul National University)

Fall 2015

Merit-based Scholarship (Yonsei University)

Fall 2012, Spring 2007

PROJECTS

Insider threat detection, Samsung SDS

January 2024 - Present

Malware detection, Samsung SDS

January 2023 - December 2023

Time-series anomaly detection, Samsung SDS

July 2022- June 2023

Synthetic data generation, Samsung SDS

September 2021 - June 2022

Statistical research for semiconductor manufacturing data, Samsung Electronics, DS division

Fall 2018 - August 2021

Development of the cost estimation methods for radar systems, Agency for Defence Development (ADD)

December 2016 - November 2017

PUBLICATIONS * Corresponding author, † Equal contribution.

Suji Lee, Sukjin Han, **Sewon Park**^{*}, Kyeongwon Lee, and Jaeyong Lee. (2019) Korean speech recognition using deep learning (in Korean). *The Korean Journal of Applied Statistics*, 32 (2), pp. 213-227.

Jayoung Kim, Chaejeong Lee, Yehjin Shin, **Sewon Park**, Minjung Kim, Noseong Park, and Jihoon Cho. (2022, August). SOS: Score-based oversampling for tabular data. In *Proceedings of the 28th ACM SIGKDD Conference on Knowledge Discovery and Data Mining (KDD '22)*, pp. 762-772.

Sewon Park^{*}, Kyeongwon Lee, Da-Eun Jeong, Heung-Kook Ko and Jaeyong Lee. (2023, May) Bayesian Nonparametric Classification for Incomplete Data With a High Missing Rate: an Application to Semiconductor Manufacturing Data. *IEEE Transactions on Semiconductor Manufacturing*, 36 (2), pp. 170-179.

Sewon Park^{*}, Hee-Seok Oh, and Jaeyong Lee. (2023, October) Lévy Adaptive B-Spline Regression via Overcomplete Systems. *Statistica Sinica*, 33 (4).

Haksoo Lim, **Sewon Park**[†], Minjung Kim, Jaehoon Lee, Seonkyu Lim, and Noseong Park. (2023, October). MadSGM: Multivariate Anomaly Detection with Score-based Generative Models. In *Proceedings of the 32nd ACM International Conference on Information and Knowledge Management* (pp. 1411-1420).

Jinsung Jeon, Jaehyeon Park, **Sewon Park**, Minjung Kim, Jeongwhan Choi and Noseong Park. (2025, April). Possibility for Proactive Anomaly Detection. In *Proceedings of the ICLR Workshop on ICBINB*.

PAPERS IN PREPARATION

Haksoo Lim, Jaehoon Lee, Minjung Kim, **Sewon Park**, and Noseong Park. TSGM: Regular and Irregular Time-series Generation using Score-based Generative Models. *Submitted*.

Kwangmin Lee, **Sewon Park**^{*}, Seongmin Kim and Jaeyong Lee. Bayesian inference for high-dimensional spiked covariance models: eigenstructure estimation with bias correction under inverse-Wishart prior. *Submitted*.

Seongmin Kim, Kwangmin Lee, **Sewon Park** and Jaeyong Lee. Eigenstructure inference for high-dimensional covariance with generalized shrinkage inverse-Wishart prior. *Submitted*.

TECHNICAL SKILLS

R (Excellent), Python (Excellent), PyTorch (Excellent), C/C++ (Advanced)